

# 74ALVT16240

16-bit inverting buffer/driver; 3-state

Rev. 03 — 4 July 2005

Product data sheet

## 1. General description

The 74ALVT16240 is a high-performance BiCMOS device designed for  $V_{CC}$  operation at 2.5 V or 3.3 V with I/O compatibility up to 5 V.

The 74ALVT16240 is an inverting 16-bit buffer that is ideal for driving bus lines. The device features four output enable inputs ( $1\overline{OE}$ ,  $2\overline{OE}$ ,  $3\overline{OE}$ ,  $4\overline{OE}$ ), each controlling four of the 3-state outputs.

## 2. Features

- 5 V I/O compatible
- Live insertion and extraction permitted
- 3-state buffers
- Power-up 3-state
- Output capability: +64 mA and -32 mA
- Latch-up protection:
  - ◆ JESD 78 exceeds 500 mA
- Electrostatic discharge protection:
  - ◆ MIL STD 883 method 3015: exceeds 2000 V
  - ◆ Machine model: exceeds 200 V
- Bus hold data inputs eliminate need for external pull-up resistors to hold unused inputs
- 16-bit bus interface
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- No bus current loading when output is tied to 5 V bus

## 3. Quick reference data

Table 1: Quick reference data

$T_{amb} = 25^\circ C$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{PLH}$	propagation delay nAx to $n\overline{Y}x$	$C_L = 50 \text{ pF}; V_{CC} = 2.5 \text{ V}$	1.0	2.5	3.7	ns
		$C_L = 50 \text{ pF}; V_{CC} = 3.3 \text{ V}$	0.5	1.7	3.0	ns
$t_{PHL}$	propagation delay nAx to $n\overline{Y}x$	$C_L = 50 \text{ pF}; V_{CC} = 2.5 \text{ V}$	1.0	1.9	2.9	ns
		$C_L = 50 \text{ pF}; V_{CC} = 3.3 \text{ V}$	0.5	1.7	2.6	ns
$C_i$	input capacitance on $n\overline{OE}$	$V_I = 0 \text{ V or } V_{CC}$	-	3	-	pF

**PHILIPS**

**Table 1:** Quick reference data ...continued  
 $T_{amb} = 25^\circ\text{C}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$C_o$	output capacitance	$V_{I/O} = 0 \text{ V or } V_{CC}$	-	9	-	pF
$I_{CC}$	supply current	outputs disabled; $V_{CC} = 2.5 \text{ V}$	-	40	100	$\mu\text{A}$
		outputs disabled; $V_{CC} = 3.3 \text{ V}$	-	60	100	$\mu\text{A}$

## 4. Ordering information

**Table 2:** Ordering information

Type number	Package				Version
	Temperature range	Name	Description		
74ALVT16240DL	-40 °C to +85 °C	SSOP48	plastic shrink small outline package; 48 leads; body width 7.5 mm		SOT370-1
74ALVT16240DGG	-40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm		SOT362-1

## 5. Functional diagram

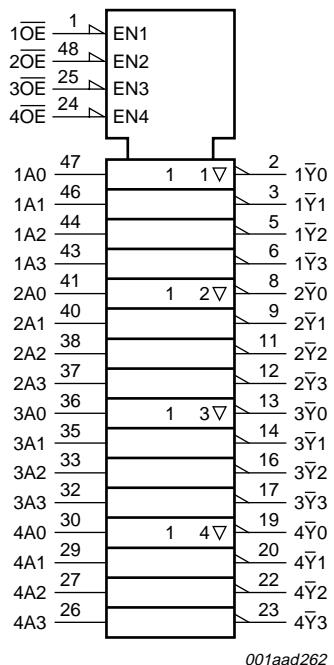


Fig 1. Logic symbol

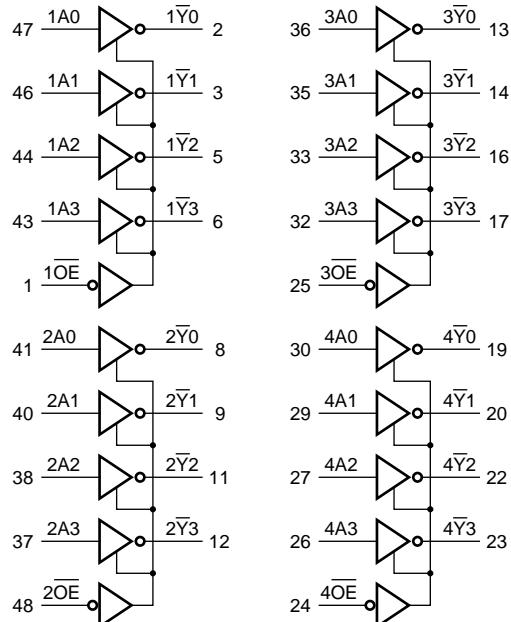
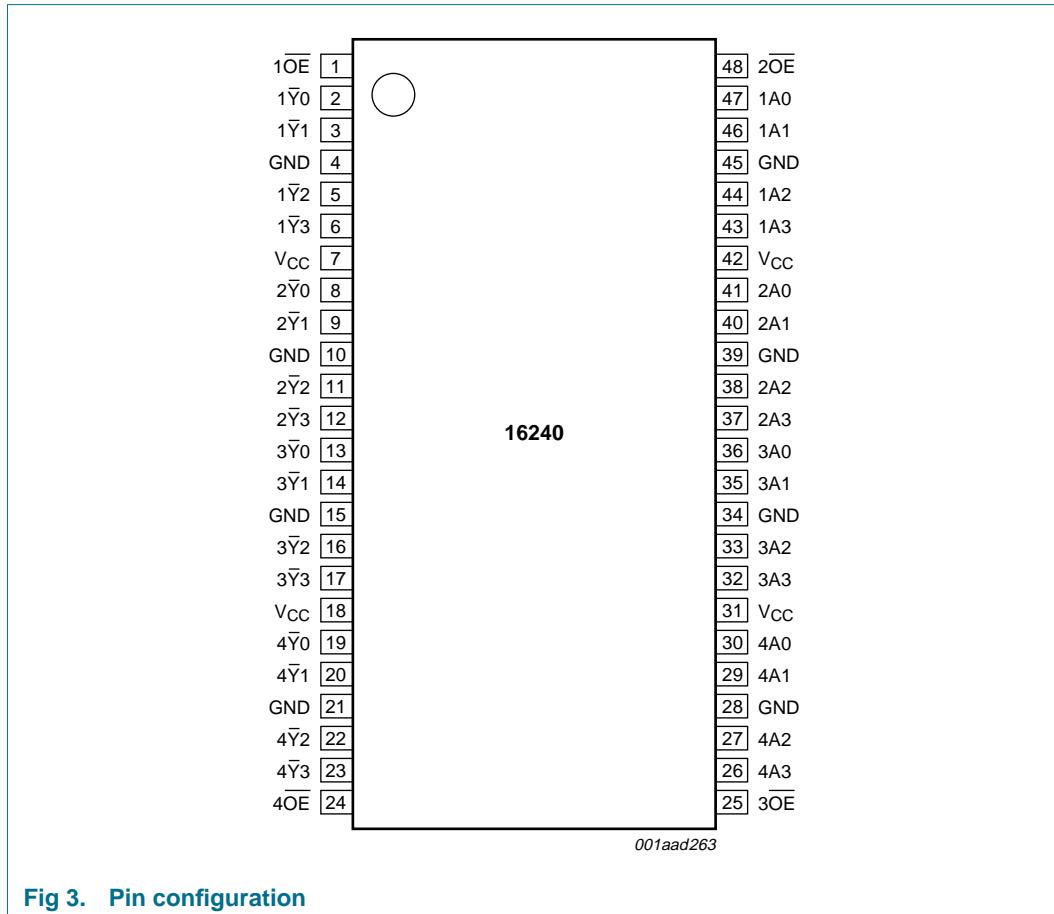


Fig 2. Logic diagram

## 6. Pinning information

### 6.1 Pinning



### 6.2 Pin description

Table 3: Pin description

Symbol	Pin	Description
1 $\overline{OE}$	1	output enable input (active LOW)
1 $\overline{Y}_0$	2	data output
1 $\overline{Y}_1$	3	data output
GND	4	ground (0 V)
1 $\overline{Y}_2$	5	data output
1 $\overline{Y}_3$	6	data output
V <sub>CC</sub>	7	supply voltage
2 $\overline{Y}_0$	8	data output
2 $\overline{Y}_1$	9	data output
GND	10	ground (0 V)
2 $\overline{Y}_2$	11	data output

**Table 3:** Pin description ...*continued*

<b>Symbol</b>	<b>Pin</b>	<b>Description</b>
2 $\bar{Y}$ 3	12	data output
3 $\bar{Y}$ 0	13	data output
3 $\bar{Y}$ 1	14	data output
GND	15	ground (0 V)
3 $\bar{Y}$ 2	16	data output
3 $\bar{Y}$ 4	17	data output
V <sub>CC</sub>	18	supply voltage
4 $\bar{Y}$ 0	19	data output
4 $\bar{Y}$ 1	20	data output
GND	21	ground (0 V)
4 $\bar{Y}$ 2	22	data output
4 $\bar{Y}$ 3	23	data output
4 $\bar{OE}$	24	output enable input (active LOW)
3 $\bar{OE}$	25	output enable input (active LOW)
4A3	26	data input
4A2	27	data input
GND	28	ground (0 V)
4A1	29	data input
4A0	30	data input
V <sub>CC</sub>	31	supply voltage
3A3	32	data input
3A2	33	data input
GND	34	ground (0 V)
3A1	35	data input
3A0	36	data input
2A3	37	data input
2A2	38	data input
GND	39	ground (0 V)
2A1	40	data input
2A0	41	data input
V <sub>CC</sub>	42	supply voltage
1A3	43	data input
1A2	44	data input
GND	45	ground (0 V)
1A1	46	data input
1A0	47	data input
2 $\bar{OE}$	48	output enable input (active LOW)



## 7. Functional description

### 7.1 Function table

**Table 4: Function table [1]**

Input		Output
$n\bar{O}E$	$nAx$	$n\bar{Y}x$
L	L	H
L	H	L
H	X	Z

- [1] H = HIGH voltage level;
- L = LOW voltage level;
- X = don't care;
- Z = high-impedance OFF-state.

## 8. Limiting values

**Table 5: Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to ground.

Symbol	Parameter	Conditions	Min	Max	Unit	
$V_{CC}$	supply voltage		-0.5	+4.6	V	
$I_{IK}$	input diode current	$V_I < 0$ V	-	-50	mA	
$V_I$	input voltage		[1]	-0.5	+7.0	V
$I_{OK}$	output diode current	$V_O < 0$ V	-	-50	mA	
$V_O$	output voltage	output in OFF-state or HIGH-state	[1]	-0.5	+7.0	V
$I_O$	output current	output in LOW-state	-	128	mA	
		output in HIGH-state	-	-64	mA	
$T_{STG}$	storage temperature		-65	+150	°C	
$T_j$	junction temperature		[2]	-	+150	°C

- [1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- [2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

## 9. Recommended operating conditions

**Table 6: Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b><math>V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}</math></b>						
$V_{CC}$	supply voltage		2.3	-	2.7	V
$V_I$	input voltage		0	-	5.5	V
$V_{IH}$	HIGH-level input voltage		1.7	-	-	V
$V_{IL}$	LOW-level input voltage		-	-	0.7	V
$I_{OH}$	HIGH-level output current		-	-	-8	mA
$I_{OL}$	LOW-level output current	none	-	-	8	mA
		current duty cycle $\leq 50\%$ ; $f \geq 1 \text{ kHz}$	-	-	24	mA
$\Delta t/\Delta V$	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
$T_{amb}$	ambient temperature	in free air	-40	-	+85	°C
<b><math>V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}</math></b>						
$V_{CC}$	supply voltage		3.0	-	3.6	V
$V_I$	input voltage		0	-	5.5	V
$V_{IH}$	HIGH-level input voltage		2.0	-	-	V
$V_{IL}$	LOW-level input voltage		-	-	0.8	V
$I_{OH}$	HIGH-level output current		-	-	-32	mA
$I_{OL}$	LOW-level output current	none	-	-	32	mA
		current duty cycle $\leq 50\%$ ; $f \geq 1 \text{ kHz}$	-	-	64	mA
$\Delta t/\Delta V$	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
$T_{amb}$	ambient temperature	in free air	-40	-	+85	°C

## 10. Static characteristics

**Table 7: Static characteristics**At recommended operating conditions; voltages are referred to GND (ground = 0 V);  $T_{amb} = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
<b><math>V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}</math> [1]</b>							
$V_{IK}$	input diode voltage	$V_{CC} = 2.3 \text{ V}; I_{IK} = -18 \text{ mA}$	-	-0.85	-1.2	V	
$V_{OH}$	HIGH-level output voltage	$V_{CC} = 2.3 \text{ V}$ to $3.6 \text{ V}; I_{OH} = -100 \mu\text{A}$	$V_{CC} - 0.2$	$V_{CC}$	-	V	
		$V_{CC} = 2.3 \text{ V}; I_{OH} = -8 \text{ mA}$	1.8	2.5	-	V	
$V_{OL}$	LOW-level output voltage	$V_{CC} = 2.3 \text{ V}$					
		$I_{OL} = 100 \mu\text{A}$	-	0.07	0.2	V	
		$I_{OL} = 24 \text{ mA}$	-	0.3	0.5	V	
		$I_{OL} = 8 \text{ mA}$	-	-	0.4	V	
$I_{LI}$	input leakage current						
	control pins	$V_{CC} = 2.7 \text{ V}; V_I = V_{CC}$ or GND	-	0.1	$\pm 1$	$\mu\text{A}$	
		$V_{CC} = 0 \text{ V}$ or $2.7 \text{ V}; V_I = 5.5 \text{ V}$	-	0.1	10	$\mu\text{A}$	
	data pins	$V_{CC} = 2.7 \text{ V}; V_I = V_{CC}$	[2]	-	0.1	1	$\mu\text{A}$
		$V_{CC} = 2.7 \text{ V}; V_I = 0 \text{ V}$	[2]	-	$+0.1$	-5	$\mu\text{A}$
$I_{OFF}$	power-down output current	$V_{CC} = 0 \text{ V}; V_O$ or $V_I = 0 \text{ V}$ to $4.5 \text{ V}$	-	0.1	$\pm 100$	$\mu\text{A}$	
$I_{HOLD}$	bus hold current on data inputs	$V_{CC} = 2.3 \text{ V}; V_I = 0.7 \text{ V}$	[3]	-	90	-	$\mu\text{A}$
		$V_{CC} = 2.3 \text{ V}; V_I = 1.7 \text{ V}$	[3]	-	-10	-	$\mu\text{A}$
$I_{EX}$	external current into output	output HIGH-state; $V_O = 5.5 \text{ V}$ ; $V_{CC} = 2.3 \text{ V}$	-	10	125	$\mu\text{A}$	
$I_{PU}$	power-up 3-state output current	$V_{CC} \leq 1.2 \text{ V}; V_O = 0.5 \text{ V}$ to $V_{CC}$ ; $V_I = \text{GND}$ or $V_{CC}$	[4]	-	1	$\pm 100$	$\mu\text{A}$
$I_{PD}$	power-down 3-state output current	$V_{CC} \leq 1.2 \text{ V}; V_O = 0.5 \text{ V}$ to $V_{CC}$ ; $V_I = \text{GND}$ or $V_{CC}$	[4]	-	1	$\pm 100$	$\mu\text{A}$
$I_{OZ}$	3-state output current	$V_{CC} = 2.7 \text{ V}; V_I = V_{IL}$ or $V_{IH}$					
		output HIGH-state; $V_O = 2.3 \text{ V}$	-	0.5	5	$\mu\text{A}$	
		output LOW-state; $V_O = 0.5 \text{ V}$	-	$+0.5$	-5	$\mu\text{A}$	
$I_{CC}$	supply current	$V_{CC} = 2.7 \text{ V}; V_I = \text{GND}$ or $V_{CC}; I_O = 0 \text{ A}$					
		outputs HIGH-state	-	0.04	0.1	mA	
		outputs LOW-state	-	2.7	4.5	mA	
		outputs disabled	[5]	-	0.04	0.1	mA
$\Delta I_{CC}$	additional supply current per input pin	$V_{CC} = 2.3 \text{ V}$ to $2.7 \text{ V}$ ; one input at $V_{CC} - 0.6 \text{ V}$ ; other inputs at $V_{CC}$ or GND	[6]	-	0.04	0.4	mA
$C_i$	input capacitance on $\overline{nOE}$	$V_I = 0 \text{ V}$ or $V_{CC}$	-	3	-	pF	
$C_o$	output capacitance	$V_{I/O} = 0 \text{ V}$ or $V_{CC}$	-	9	-	pF	
<b><math>V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}</math> [7]</b>							
$V_{IK}$	input diode voltage	$V_{CC} = 3.0 \text{ V}; I_{IK} = -18 \text{ mA}$	-	-0.85	-1.2	V	
$V_{OH}$	HIGH-level output voltage	$V_{CC} = 3.0 \text{ V}$ to $3.6 \text{ V}; I_{OH} = -100 \mu\text{A}$	$V_{CC} - 0.2$	$V_{CC}$	-	V	
		$V_{CC} = 3.0 \text{ V}; I_{OH} = -32 \text{ mA}$	2.0	2.3	-	V	

**Table 7: Static characteristics ...continued**At recommended operating conditions; voltages are referred to GND (ground = 0 V);  $T_{amb} = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{OL}$	LOW-level output voltage	$V_{CC} = 3.0\text{ V}$				
		$I_{OL} = 100\text{ }\mu\text{A}$	-	0.07	0.2	V
		$I_{OL} = 16\text{ mA}$	-	0.25	0.4	V
		$I_{OL} = 32\text{ mA}$	-	0.3	0.5	V
		$I_{OL} = 64\text{ mA}$	-	0.4	0.55	V
$I_{LI}$	input leakage current					
		control pins	$V_{CC} = 3.6\text{ V}; V_I = V_{CC}$ or GND	-	0.1	$\pm 1$ $\mu\text{A}$
			$V_{CC} = 0\text{ V}$ or $3.6\text{ V}; V_I = 5.5\text{ V}$	-	0.1	10 $\mu\text{A}$
		data pins	$V_{CC} = 3.6\text{ V}; V_I = V_{CC}$	[2]	0.5	1 $\mu\text{A}$
			$V_{CC} = 3.6\text{ V}; V_I = 0\text{ V}$	[2]	+0.1	-5 $\mu\text{A}$
$I_{OFF}$	power-down output current	$V_{CC} = 0\text{ V}; V_I$ or $V_O = 0\text{ V}$ to $4.5\text{ V}$	-	0.1	$\pm 100$	$\mu\text{A}$
$I_{HOLD}$	bus hold current on data inputs	$V_{CC} = 3\text{ V}; V_I = 0.8\text{ V}$	[3]	75	130	- $\mu\text{A}$
		$V_{CC} = 3\text{ V}; V_I = 2.0\text{ V}$	[3]	-75	-140	- $\mu\text{A}$
		$V_{CC} = 0\text{ V}$ to $3.6\text{ V}; V_I = 3.6\text{ V}$	[3]	$\pm 500$	-	- $\mu\text{A}$
$I_{PU}$	power-up 3-state output current	$V_{CC} \leq 1.2\text{ V}; V_O = 0.5\text{ V}$ to $V_{CC}$ ; $V_I = \text{GND}$ or $V_{CC}$	[8]	-	1	$\pm 100$ $\mu\text{A}$
$I_{PD}$	power-down 3-state output current	$V_{CC} \leq 1.2\text{ V}; V_O = 0.5\text{ V}$ to $V_{CC}$ ; $V_I = \text{GND}$ or $V_{CC}$	[8]	-	1	$\pm 100$ $\mu\text{A}$
$I_{OZ}$	3-state output current	$V_{CC} = 3.6\text{ V}; V_I = V_{IL}$ or $V_{IH}$				
		output HIGH-state; $V_O = 3.0\text{ V}$	-	0.5	5	$\mu\text{A}$
		output LOW-state; $V_O = 0.5\text{ V}$	-	+0.5	-5	$\mu\text{A}$
$I_{CC}$	supply current	$V_{CC} = 3.6\text{ V}; V_I = \text{GND}$ or $V_{CC}$ ; $I_O = 0\text{ A}$				
		outputs HIGH-state	-	0.05	0.1	mA
		outputs LOW-state	-	3.9	5.5	mA
		outputs disabled	[5]	-	0.06	0.1 mA
$\Delta I_{CC}$	additional supply current per input pin	$V_{CC} = 3\text{ V}$ to $3.6\text{ V}$ ; one input at $V_{CC} - 0.6\text{ V}$ ; other inputs at $V_{CC}$ or GND	[6]	-	0.04	0.4 mA

[1] All typical values are at  $V_{CC} = 2.5\text{ V}$  and  $T_{amb} = 25^{\circ}\text{C}$ .[2] Unused pins at  $V_{CC}$  or GND.

[3] This is the bus hold overdrive current required to force the input to the opposite logic state.

[4] This parameter is valid for any  $V_{CC}$  between  $0\text{ V}$  and  $1.2\text{ V}$  with a transition time of up to 10 ms. From  $V_{CC} = 1.2\text{ V}$  to  $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$  a transition time of  $100\text{ }\mu\text{s}$  is permitted. This parameter is valid for  $T_{amb} = 25^{\circ}\text{C}$  only.[5]  $I_{CC}$  is measured with outputs pulled up to  $V_{CC}$  or pulled down to ground.[6] This is the increase in supply current for each input at the specified voltage level other than  $V_{CC}$  or GND.[7] All typical values are at  $V_{CC} = 3.3\text{ V}$  and  $T_{amb} = 25^{\circ}\text{C}$ .[8] This parameter is valid for any  $V_{CC}$  between  $0\text{ V}$  and  $1.2\text{ V}$  with a transition time of up to 10 ms. From  $V_{CC} = 1.2\text{ V}$  to  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$  a transition time of  $100\text{ }\mu\text{s}$  is permitted. This parameter is valid for  $T_{amb} = 25^{\circ}\text{C}$  only.

## 11. Dynamic characteristics

**Table 8: Dynamic characteristics**

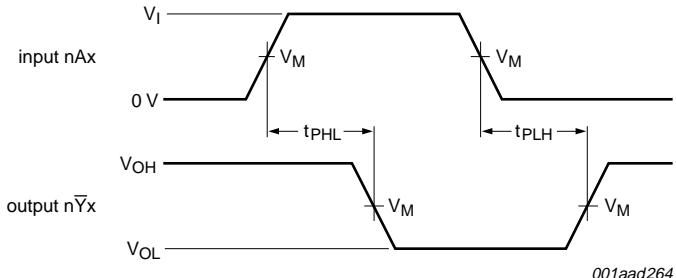
*GND = 0 V;  $T_{amb} = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ ; for test circuit see [Figure 6](#).*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b><math>V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}</math> [1]</b>						
$t_{PLH}$	propagation delay nAx to n $\bar{Y}_x$	see <a href="#">Figure 4</a>	1.0	2.5	3.7	ns
$t_{PHL}$	propagation delay nAx to n $\bar{Y}_x$	see <a href="#">Figure 4</a>	1.0	1.9	2.9	ns
$t_{PZH}$	output enable time to HIGH-level	see <a href="#">Figure 5</a>	1.0	3.3	5.3	ns
$t_{PZL}$	output enable time to LOW-level	see <a href="#">Figure 5</a>	1.0	2.6	4.2	ns
$t_{PHZ}$	output disable time from HIGH-level	see <a href="#">Figure 5</a>	1.0	2.5	4.0	ns
$t_{PLZ}$	output disable time from LOW-level	see <a href="#">Figure 5</a>	1.0	1.8	3.0	ns
<b><math>V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}</math> [2]</b>						
$t_{PLH}$	propagation delay nAx to n $\bar{Y}_x$	see <a href="#">Figure 4</a>	0.5	1.7	3.0	ns
$t_{PHL}$	propagation delay nAx to n $\bar{Y}_x$	see <a href="#">Figure 4</a>	0.5	1.7	2.6	ns
$t_{PZH}$	output enable time to HIGH-level	see <a href="#">Figure 5</a>	1.0	2.5	3.2	ns
$t_{PZL}$	output enable time to LOW-level	see <a href="#">Figure 5</a>	1.0	1.9	3.1	ns
$t_{PHZ}$	output disable time from HIGH-level	see <a href="#">Figure 5</a>	1.5	2.8	4.1	ns
$t_{PLZ}$	output disable time from LOW-level	see <a href="#">Figure 5</a>	1.5	2.3	3.4	ns

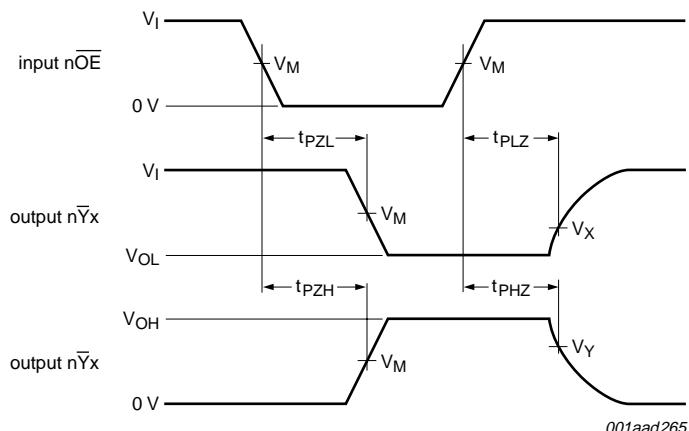
[1] All typical values are at  $V_{CC} = 2.5 \text{ V}$  and  $T_{amb} = 25^{\circ}\text{C}$ .

[2] All typical values are at  $V_{CC} = 3.3 \text{ V}$  and  $T_{amb} = 25^{\circ}\text{C}$ .

## 12. Waveforms



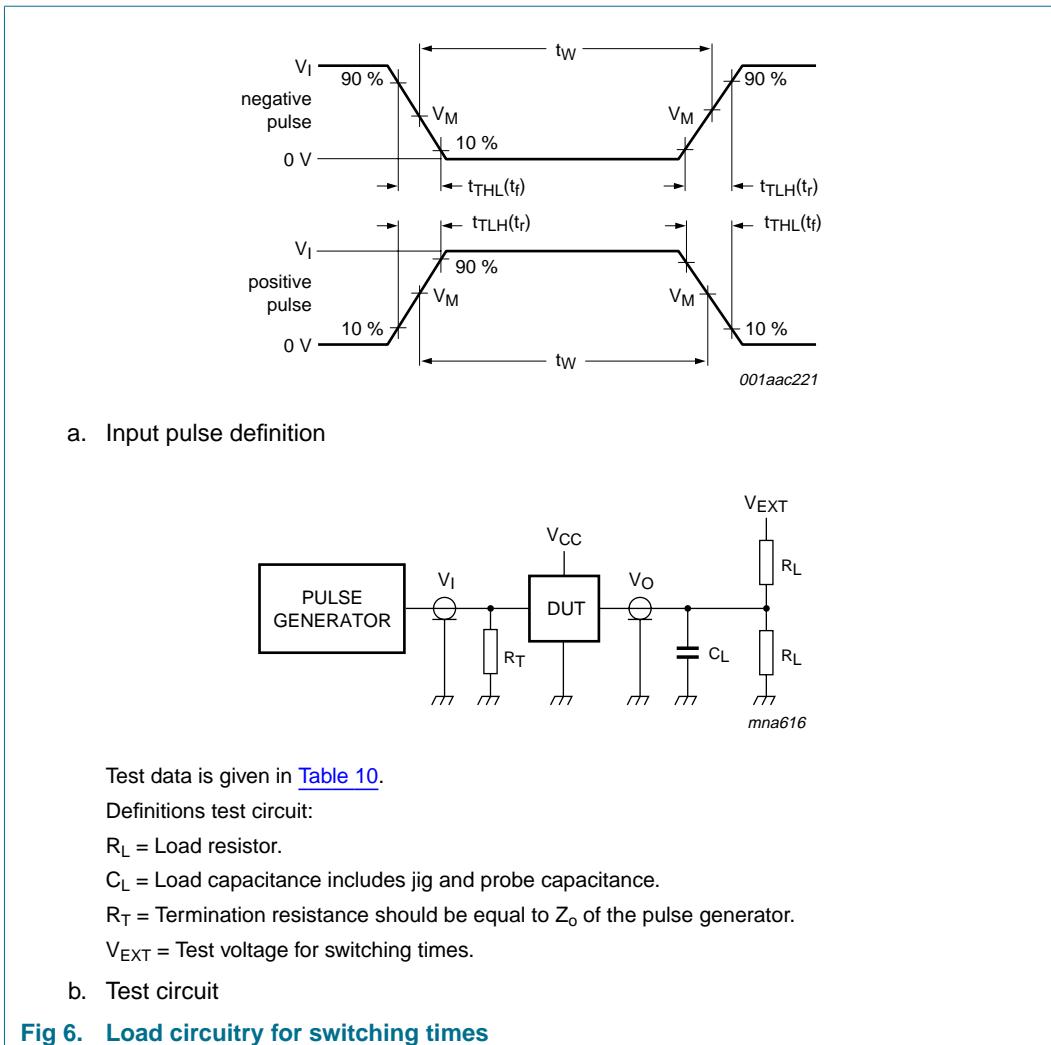
**Fig 4. Input (nAx) to output (nYx) propagation delays**



**Fig 5. 3-state output enable and disable times**

**Table 9: Measurement points**

Supply voltage	Input	Output		
$V_{CC}$	$V_M$	$V_M$	$V_X$	$V_Y$
$\geq 3 \text{ V}$	1.5 V	1.5 V	$V_{OL} + 0.3 \text{ V}$	$V_{OH} - 0.3 \text{ V}$
$\leq 2.7 \text{ V}$	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	$V_{OL} + 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$



Test data is given in [Table 10](#).

Definitions test circuit:

$R_L$  = Load resistor.

$C_L$  = Load capacitance includes jig and probe capacitance.

$R_T$  = Termination resistance should be equal to  $Z_o$  of the pulse generator.

$V_{EXT}$  = Test voltage for switching times.

#### b. Test circuit

**Fig 6. Load circuitry for switching times**

**Table 10: Test data**

Input				Load		$V_{EXT}$		
$V_I$	$f_i$	$t_W$	$t_r, t_f$	$C_L$	$R_L$	$t_{PHZ}, t_{PZH}$	$t_{PLZ}, t_{PZL}$	$t_{PLH}, t_{PHL}$
3.0 V or $V_{CC}$ whichever is less	$\leq 10$ MHz	500 ns	$\leq 2.5$ ns	50 pF	500 $\Omega$	GND	6 V or $2 \times V_{CC}$	open

## 13. Package outline

SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1

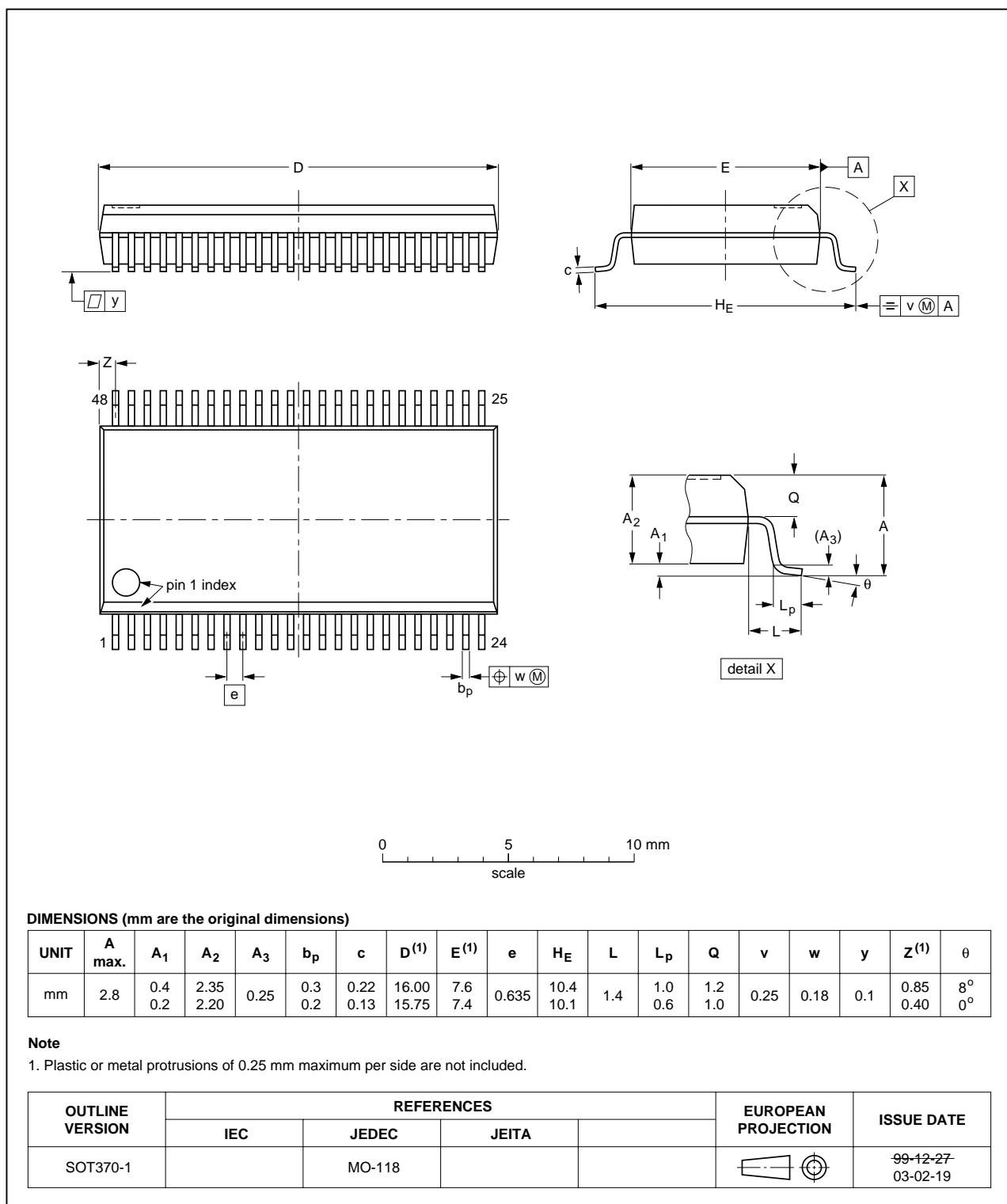


Fig 7. Package outline SOT370-1 (SSOP48)

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1

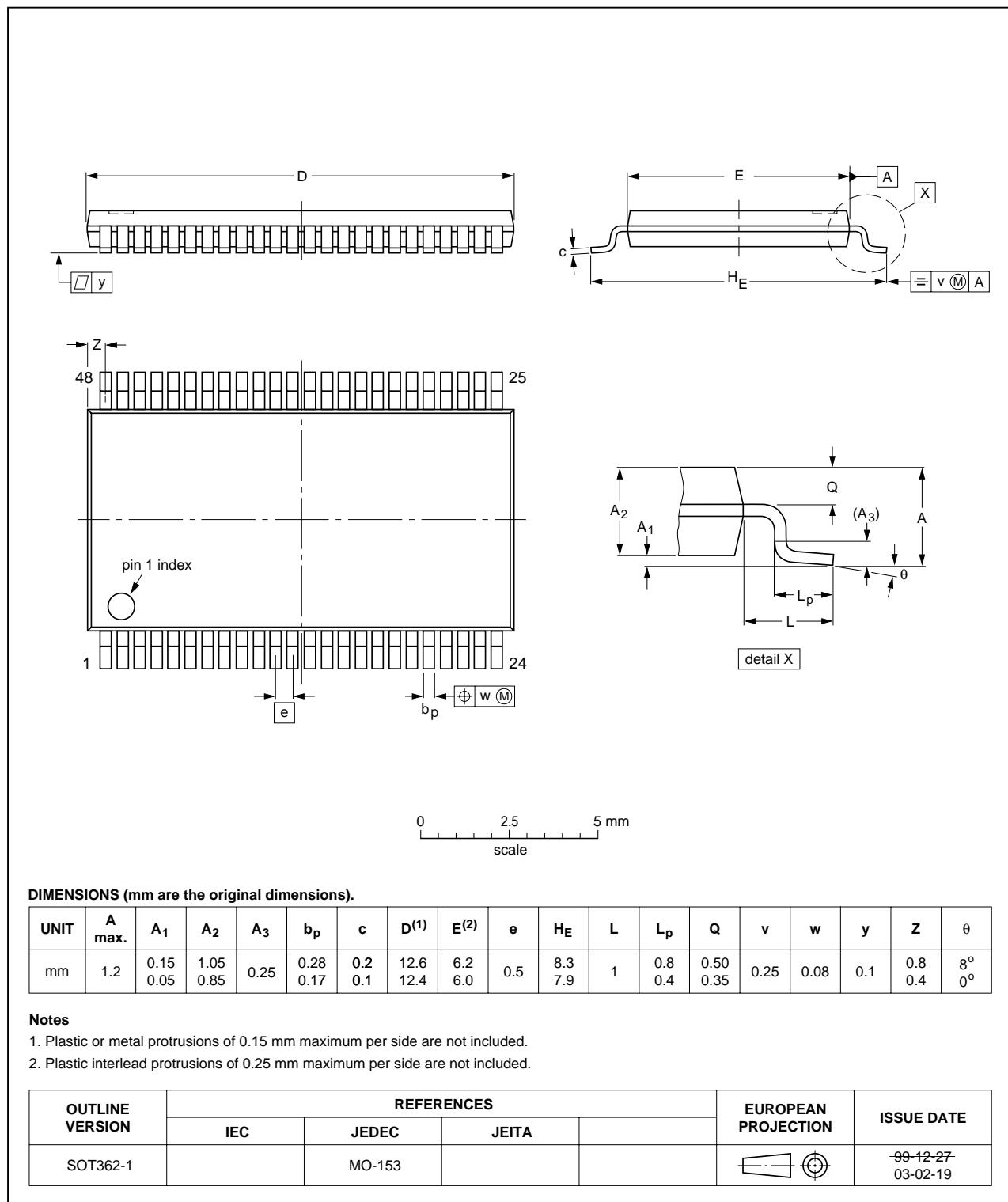


Fig 8. Package outline SOT362-1 (TSSOP48)

## 14. Revision history

**Table 11: Revision history**

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
74ALVT16240_3	20050704	Product data sheet	-	9397 750 15192	74ALVT16240_2
Modifications:	<ul style="list-style-type: none"><li>The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors.</li><li>In <a href="#">Table 8</a>; update of the typical and maximum value of <math>t_{PZH}</math> at <math>V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}</math></li></ul>				
74ALVT16240_2	19980213	Product specification	-	9397 750 03615	74ALVT16240_1
74ALVT16240_1	19970502	-	-	-	-

## 15. Data sheet status

Level	Data sheet status [1]	Product status [2][3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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## 19. Contact information

For additional information, please visit: <http://www.semiconductors.philips.com>

For sales office addresses, send an email to: [sales.addresses@www.semiconductors.philips.com](mailto:sales.addresses@www.semiconductors.philips.com)



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